

#### **Features**

- Split Gate Trench MOSFET technology
- Excellent package for heat dissipation
- High density cell design for low RDS(ON)

### **Product Summary**

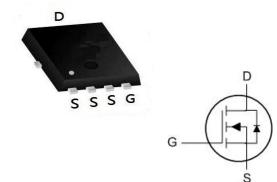


BVDSS	RDSON	ID
60V	10mΩ	50A

## **Applications**

- DC-DC Converters
- Power management functions
- Synchronous-rectification applications

#### PDFN5060-8L Pin Configuration



### **Absolute Maximum Ratings**

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	60	V
V <sub>GS</sub>	Gate-Source Voltage	±20	V
I <sub>D</sub> @T <sub>C</sub> =25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1,6</sup>	50	Α
I <sub>D</sub> @T <sub>C</sub> =100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1,6</sup>	25	Α
I <sub>DM</sub>	Pulsed Drain Current <sup>2</sup>	160	Α
EAS	Single Pulse Avalanche Energy³	49	mJ
las	Avalanche Current	14	Α
P <sub>D</sub> @T <sub>C</sub> =25°C	Total Power Dissipation <sup>4</sup>	33	W
T <sub>STG</sub>	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

#### **Thermal Data**

Symbol	Parameter	Тур.	Max.	Unit
R <sub>θJA</sub>	Thermal Resistance Junction-Ambient <sup>1</sup>		55	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>		3.8	°C/W



### Electrical Characteristics (T<sub>J</sub>=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV <sub>DSS</sub>	Drain-Source Breakdown Voltage	V <sub>GS</sub> =0V , I <sub>D</sub> =250uA	60			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BV <sub>DSS</sub> Temperature Coefficient Reference to 25°C , I <sub>D</sub> =1mA					V/°C	
В	Static Dunin Course On Besistance?	V <sub>GS</sub> =10V , I <sub>D</sub> =1A		10	12.5	0	
R <sub>DS(ON)</sub>	Static Drain-Source On-Resistance <sup>2</sup>	V <sub>GS</sub> =4.5V , I <sub>D</sub> =1A		13	16	mΩ	
V <sub>GS(th)</sub>	Gate Threshold Voltage	\/ -\/   -250\	1	1.45	2.5	V	
$\triangle V_{GS(th)}$	V <sub>GS(th)</sub> Temperature Coefficient	$-V_{GS}=V_{DS}$ , $I_D=250uA$				mV/°C	
	Drain-Source Leakage Current	V <sub>DS</sub> =60V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			1		
I <sub>DSS</sub>	Dialii-Source Leakage Current	$V_{DS}$ =60V, $V_{GS}$ =0V , $T_J$ =100 $^{\circ}$ C				uA	
I <sub>GSS</sub>	Gate-Source Leakage Current	$V_{GS} = \pm 20V$ , $V_{DS} = 0V$			±100	nA	
gfs	Forward Transconductance	V <sub>DS</sub> =10V , I <sub>D</sub> =20A				S	
R <sub>g</sub>	Gate Resistance	V <sub>DS</sub> =0V , V <sub>GS</sub> =0V , f=1MHz				Ω	
Qg	Total Gate Charge			33			
Q <sub>gs</sub>	Gate-Source Charge	V <sub>DS</sub> =30V , V <sub>GS</sub> =10V , I <sub>D</sub> =10A		5.3		nC	
$Q_{gd}$	Gate-Drain Charge			31.5			
T <sub>d(on)</sub>	Turn-On Delay Time			9			
Tr	Rise Time	$V_{GS}$ =10V, $V_{DD}$ =30V,		19.4			
T <sub>d(off)</sub>	Turn-Off Delay Time	$I_D=10A$ , $R_{GEN}=4.7\Omega$		14.8		ns	
T <sub>f</sub>	Fall Time			8.9			
C <sub>iss</sub>	Input Capacitance			915			
Coss	Output Capacitance	out Capacitance V <sub>DS</sub> =30V , V <sub>GS</sub> =0V , f=1MHz		370		pF	
C <sub>rss</sub>	Reverse Transfer Capacitance			30			

#### **Diode Characteristics**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
ls	Continuous Source Current <sup>1,4</sup>	V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			50	А
VsD	Diode Forward Voltage <sup>2</sup>	V <sub>GS</sub> =0V , I <sub>S</sub> =20A , T <sub>J</sub> =250			1.2	V

#### Notes:

- 1. Repetitive rating, pulse width limited by junction temperature  $T_{J(MAX)}$ =150°C.
- 2. The test condition is  $V_{\text{DD}}\!\!=30V,\,V_{\text{GS}}\!\!=10V,\,L\!\!=0.5mH,\,I_{\text{AS}}\!\!=14A.$
- 3. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper, The value in any given application depends on the user's specific board design.
- 4. The data tested by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%.
- 5. This value is guaranteed by design hence it is not included in the production test.



0

1

### **N-Ch 60V Fast Switching MOSFETs**

# **Typical Performance Characteristics**

Figure 1: Output Characteristics

80

V<sub>GS</sub> = 10V

V<sub>GS</sub> = 4.5V

V<sub>GS</sub> = 4V

V<sub>GS</sub> = 3.5V

Figure 3: On-resistance vs. Drain Current

Vos(V)

3

5

4

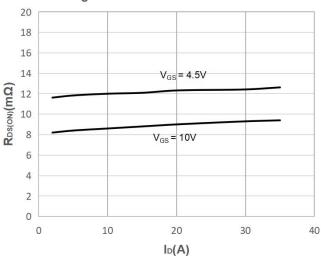


Figure 5: Gate Charge Characteristics

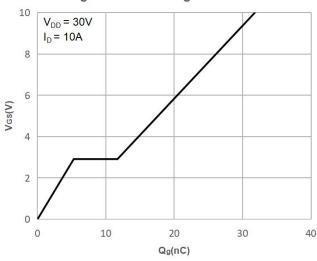


Figure 2: Typical Transfer Characteristics

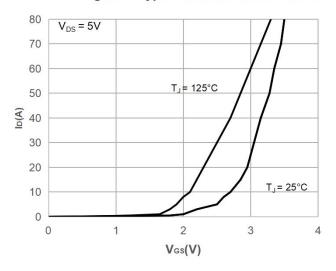


Figure 4: Body Diode Characteristics

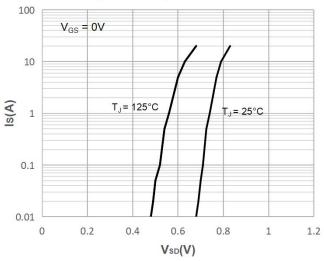


Figure 6: Capacitance Characteristics

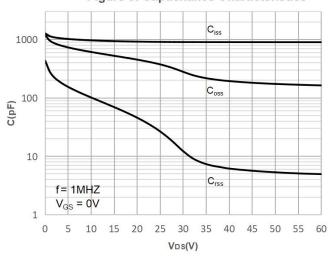




Figure 7: Normalized Breakdown voltage vs. **Junction Temperature** 

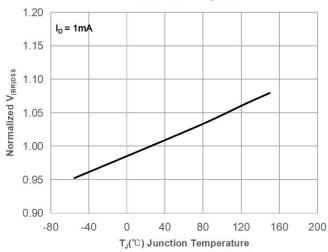
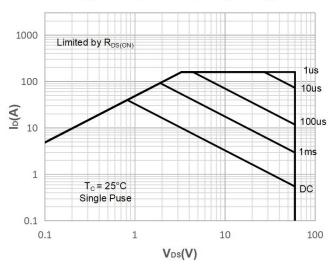


Figure 9: Maximum Safe Operating Area



**Figure 11: Normalized Maximum Transient** 

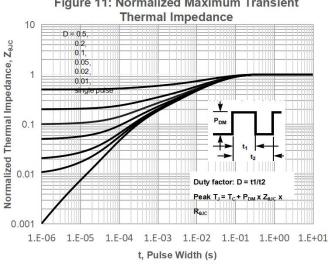


Figure 8: Normalized on Resistance vs. **Junction Temperature** 

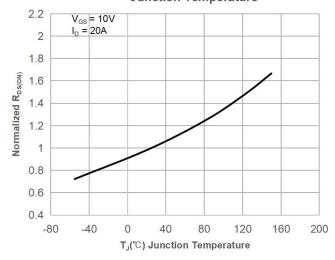


Figure 10: Maximum Continuous Drian **Current vs. Case Temperature** 

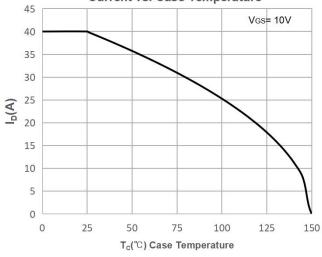
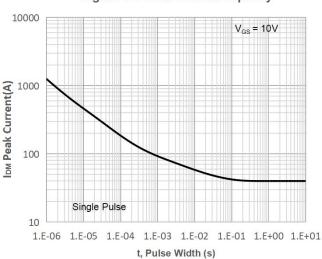
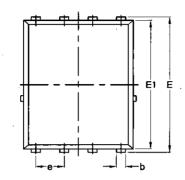


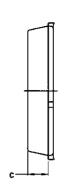
Figure 12: Peak Current Capacity

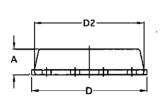


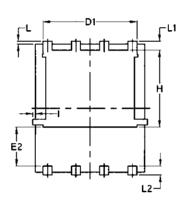


# Package Mechanical Data-PDFN5060-8L- Single









Symbol	Common	Common					
	mm	mm					
	Mim	Max	Min	Max			
Α	1.03	1.17	0.0406	0.0461			
b	0.34	0.48	0.0134	0.0189			
С	0.824	0.0970	0.0324	0.082			
D	4.80	5.40	0.1890	0.2126			
D1	4.11	4.31	0.1618	0.1697			
D2	4.80	5.00	0.1890	0.1969			
E	5.95	6.15	0.2343	0.2421			
E1	5.65	5.85	0.2224	0.2303			
E2	1.60	/	0.0630	/			
е	1.27 BSC		0.05 BSC				
L	0.05	0.25	0.0020	0.0098			
L1	0.38	0.50	0.0150	0.0197			
L2	0.38	0.50	0.0150	0.0197			
Н	3.30	3.50	0.1299	0.1378			
1	/	0.18	/	0.0070			